## THE PROTON INSERTION IN HYDROUS RUTHENIUM OXIDES

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Hydrous ruthenium oxides (RuO<sub>2</sub>.xH<sub>2</sub>O) were found to be able to store more proton than anhydrous ruthenium oxides.<sup>1,2</sup> The proton density in RuO<sub>2</sub>.xH<sub>2</sub>O was strongly dependent on the structure of the ruthenium oxide and the annealing temperature during the sample preparation. It was found that the RuO<sub>2</sub>.xH<sub>2</sub>O with the maximum proton density was always obtained at the temperature near the phase transition from amorphous to crystalline.<sup>2,3</sup>

Microstructure of RuO2.xH2O was studied by transmission electron microscope (TEM) and selected area electron diffraction (SAED) techniques. Figures 1 shows the TEM image of a chunk of particles from the RuO<sub>2</sub>.0.60H<sub>2</sub>O sample annealed at 150 °C. The maximum value of specific capacitance was obtained from this sample. It can be seen that the  $RuO_2.0.60H_2O$ was formed by particles with a size of about 50 nm. Figure 2 shows the SAED pattern from the  $RuO_2.0.60H_2O$  sample. The center position of the SAED ring corresponded to the (111) and (020) planes of rutile RuO<sub>2</sub> structure, indicated that the Ru atoms approximately remain at their positions in the rutile unit cell within the particle. It was found that the width of the ring pattern from  $RuO_2.0.60H_2O$  was narrower than that from sample prepared at low temperatures. It can be concluded that the RuO<sub>2</sub>.0.60H<sub>2</sub>O was an amorphous phase; however, became progressively more ordered in local structure than that prepared at low temperatures. Figure 3 shows the SAED pattern from a protoninserted sample of RuO(OH).0.60H2O. The broadening in SAED pattern indicated that the local order was destroyed by proton insertion.

The <sup>1</sup>H nuclear magnetic resonance spectroscopy at various temperatures was used to study the proton dynamic in  $RuO_2.xH_2O$  samples annealed at different temperatures. Figure 4 shows the proton activation energy as a function of sample annealing temperature from theoretical fittings of experimental results. It was found that that the activation energy was highly correlated with the specific capacitance. The minimum value of activation energy 2.47 kJ/mol was obtained from the sample with the maximum specific capacitance.

A model of describing the proton insertion in the bulk of RuO2.xH2O has been established based on the proton dynamic and microstructural studies of RuO<sub>2</sub>.xH<sub>2</sub>O. In the model, the structural water and the local structure of RuO2.xH2O seem to be extremely crucial for the proton transport. The proton insertion would cause a locally structural change that could only occur in amorphous phase of RuO2.xH2O. The proton insertion would easily occur in RuO2.xH2O that had a local order and less structural water content, because the proton diffusion, as a insertion mechanism, would increase with decreasing the Ru-Ru distance. Therefore, RuO<sub>2</sub>.xH<sub>2</sub>O sample annealed at 150 °C, which contented the lowest structure water in among amorphous phase of RuO2.xH2O, had the highest specific capacitance.

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- 2. J. P. Zheng, P. J. Cygan and T. R. Jow, J. *Electrochem. Soc.* **142**, 2695 (1995).
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Figure 1 TEM image from the  $RuO_2.xH_2O$  sample prepared at 150 °C with a magnification of  $500k\Delta$ .



Figure 2 SAED pattern from the  $RuO_2.xH_2O$  sample prepared at 150 °C.



Figure 3 The SAED pattern measured from the protoninserted RuO<sub>2</sub>.xH<sub>2</sub>O sample



Figure 4 The activation energy of proton in  $RuO_2.xH_2O$  samples as a function of the sample annealing temperature.